Search Notes

Application/Control	No.	

Applicant(s)/Patent under Reexamination
OTOSAKA ET AL.
Art Unit.

10/634,779

Examiner

1775

Elizabeth Ivey

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
See EAST Search	5/21/2006	EDI	